

RF Power Field Effect Transistors

N-Channel Enhancement-Mode Lateral MOSFETs

Designed for W-CDMA and LTE base station applications with frequencies from 2110 to 2170 MHz. Can be used in Class AB and Class C for all typical cellular base station modulation formats.

- Typical Doherty Single-Carrier W-CDMA Performance: $V_{DD} = 28$ Volts, $I_{DQB} = 360$ mA, $V_{GSA} = 0.4$ Vdc, $P_{out} = 28$ Watts Avg., IQ Magnitude Clipping, Channel Bandwidth = 3.84 MHz, Input Signal PAR = 9.9 dB @ 0.01% Probability on CCDF.

Frequency	G_{ps} (dB)	η_D (%)	Output PAR (dB)	ACPR (dBc)
2110 MHz	14.2	46.4	7.9	-35.4
2140 MHz	14.1	45.7	7.7	-35.3
2170 MHz	14.0	45.1	7.6	-34.8

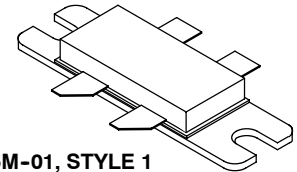
- Capable of Handling 10:1 VSWR, @ 32 Vdc, 2140 MHz, 157 Watts CW ⁽¹⁾ Output Power (3 dB Input Overdrive from Rated P_{out})
- Typical P_{out} @ 3 dB Compression Point $\approx$ 166 Watts CW ⁽¹⁾

Features

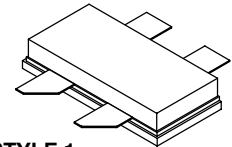
- Advanced High Performance In-Package Doherty
- Production Tested in a Doherty Configuration
- 100% PAR Tested for Guaranteed Output Power Capability
- Characterized with Large-Signal Load-Pull Parameters and Common Source S-Parameters
- Internally Matched for Ease of Use
- Integrated ESD Protection
- Greater Negative Gate-Source Voltage Range for Improved Class C Operation
- Designed for Digital Predistortion Error Correction Systems
- RoHS Compliant
- NI-780-4 in Tape and Reel. R3 Suffix = 250 Units, 56 mm Tape Width, 13 inch Reel. For R5 Tape and Reel option, see p. 8.
- NI-780S-4 in Tape and Reel. R3 Suffix = 250 Units, 32 mm Tape Width, 13 inch Reel. For R5 Tape and Reel option, see p. 8.

MRF8HP21130HR3 MRF8HP21130HSR3

**2110-2170 MHz, 28 W AVG., 28 V
W-CDMA, LTE
LATERAL N-CHANNEL
RF POWER MOSFETs**



**CASE 465M-01, STYLE 1
NI-780-4
MRF8HP21130HR3**



**CASE 465H-02, STYLE 1
NI-780S-4
MRF8HP21130HSR3**

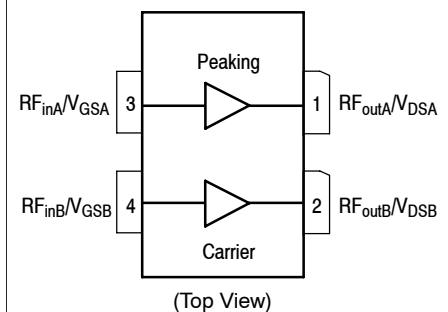


Figure 1. Pin Connections

Table 1. Maximum Ratings

Rating	Symbol	Value	Unit
Drain-Source Voltage	V_{DSS}	-0.5, +65	Vdc
Gate-Source Voltage	V_{GS}	-6.0, +10	Vdc
Operating Voltage	V_{DD}	32, +0	Vdc
Storage Temperature Range	T_{stg}	-65 to +150	°C
Case Operating Temperature	T_C	150	°C
Operating Junction Temperature ^(2,3)	T_J	225	°C
CW Operation @ $T_C = 25^\circ\text{C}$ Derate above 25°C	CW	118 0.28	W W/°C

- Exceeds recommended operating conditions. See CW operation data in Maximum Ratings table.
- Continuous use at maximum temperature will affect MTTF.
- MTTF calculator available at <http://www.freescale.com/rf>. Select Software & Tools/Development Tools/Calculators to access MTTF calculators by product.

Table 2. Thermal Characteristics

Characteristic	Symbol	Value (1,2)	Unit
Thermal Resistance, Junction to Case Case Temperature 81°C, 28 W CW, 28 Vdc, $I_{DQB} = 360$ mA, $V_{GSA} = 0.4$ Vdc, 2170 MHz Case Temperature 105°C, 110 W CW ⁽³⁾ , 28 Vdc, $I_{DQB} = 360$ mA, $V_{GSA} = 0.4$ Vdc, 2170 MHz	$R_{\theta JC}$	0.60 0.50	°C/W

Table 3. ESD Protection Characteristics

Test Methodology	Class
Human Body Model (per JESD22-A114)	1C (Minimum)
Machine Model (per EIA/JESD22-A115)	B (Minimum)
Charge Device Model (per JESD22-C101)	IV (Minimum)

Table 4. Electrical Characteristics ($T_A = 25^\circ\text{C}$ unless otherwise noted)

Characteristic	Symbol	Min	Typ	Max	Unit
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Off Characteristics ⁽⁴⁾

Zero Gate Voltage Drain Leakage Current ($V_{DS} = 65$ Vdc, $V_{GS} = 0$ Vdc)	I_{DSS}	—	—	10	μAdc
Zero Gate Voltage Drain Leakage Current ($V_{DS} = 28$ Vdc, $V_{GS} = 0$ Vdc)	I_{DSS}	—	—	1	μAdc
Gate-Source Leakage Current ($V_{GS} = 5$ Vdc, $V_{DS} = 0$ Vdc)	I_{GSS}	—	—	1	μAdc

On Characteristics - Side A ⁽⁴⁾

Gate Threshold Voltage ($V_{DS} = 10$ Vdc, $I_D = 102$ μAdc)	$V_{GS(th)}$	0.1	0.9	1.6	Vdc
Drain-Source On-Voltage ($V_{GS} = 10$ Vdc, $I_D = 1.02$ Adc)	$V_{DS(on)}$	0.1	0.2	0.3	Vdc

On Characteristics - Side B ⁽⁴⁾

Gate Threshold Voltage ($V_{DS} = 10$ Vdc, $I_D = 75$ μAdc)	$V_{GS(th)}$	1.2	1.8	2.7	Vdc
Gate Quiescent Voltage ($V_{DD} = 28$ Vdc, $I_{DB} = 360$ mA, Measured in Functional Test)	$V_{GS(Q)}$	1.9	2.6	3.4	Vdc
Drain-Source On-Voltage ($V_{GS} = 10$ Vdc, $I_D = 0.75$ Adc)	$V_{DS(on)}$	0.1	0.2	0.3	Vdc

Functional Tests ^(5,6) (In Freescale Doherty Test Fixture, 50 ohm system) $V_{DD} = 28$ Vdc, $I_{DQB} = 360$ mA, $V_{GSA} = 0.4$ Vdc, $P_{out} = 28$ W Avg., $f = 2170$ MHz, Single-Carrier W-CDMA, IQ Magnitude Clipping, Input Signal PAR = 9.9 dB @ 0.01% Probability on CCDF. ACPR measured in 3.84 MHz Channel Bandwidth @ ± 5 MHz Offset.

Power Gain	G_{ps}	13.0	14.0	16.0	dB
Drain Efficiency	η_D	42.0	45.1	—	%
Output Peak-to-Average Ratio @ 0.01% Probability on CCDF	PAR	6.7	7.6	—	dB
Adjacent Channel Power Ratio	ACPR	—	-34.8	-30.0	dBc

Typical Broadband Performance ⁽⁶⁾ (In Freescale Doherty Test Fixture, 50 ohm system) $V_{DD} = 28$ Vdc, $I_{DQB} = 360$ mA, $V_{GSA} = 0.4$ Vdc, $P_{out} = 28$ W Avg., Single-Carrier W-CDMA, IQ Magnitude Clipping, Input Signal PAR = 9.9 dB @ 0.01% Probability on CCDF. ACPR measured in 3.84 MHz Channel Bandwidth @ ± 5 MHz Offset.

Frequency	G_{ps} (dB)	η_D (%)	Output PAR (dB)	ACPR (dBc)
2110 MHz	14.2	46.4	7.9	-35.4
2140 MHz	14.1	45.7	7.7	-35.3
2170 MHz	14.0	45.1	7.6	-34.8

1. MTTF calculator available at <http://www.freescale.com/rf>. Select Software & Tools/Development Tools/Calculators to access MTTF calculators by product.
2. Refer to AN1955, *Thermal Measurement Methodology of RF Power Amplifiers*. Go to <http://www.freescale.com/rf>. Select Documentation/Application Notes - AN1955.
3. Exceeds recommended operating conditions. See CW operation data in Maximum Ratings table.
4. Each side of device measured separately.
5. Part internally matched both on input and output.
6. Measurement made with device in a Doherty configuration.

(continued)

Table 4. Electrical Characteristics ($T_A = 25^\circ\text{C}$ unless otherwise noted) **(continued)**

Characteristic	Symbol	Min	Typ	Max	Unit
Typical Performances ⁽¹⁾ (In Freescale Doherty Test Fixture, 50 ohm system) $V_{DD} = 28\text{ Vdc}$, $I_{DQB} = 360\text{ mA}$, $V_{GSA} = 0.4\text{ Vdc}$, 2110–2170 MHz Bandwidth					
P_{out} @ 1 dB Compression Point, CW	P1dB	—	130 ⁽²⁾	—	W
P_{out} @ 3 dB Compression Point, CW	P3dB	—	166 ⁽²⁾	—	W
IMD Symmetry @ 52 W PEP, P_{out} where IMD Third Order Intermodulation $\cong 30\text{ dBc}$ (Delta IMD Third Order Intermodulation between Upper and Lower Sidebands $> 2\text{ dB}$)	IMD _{sym}	—	18	—	MHz
VBW Resonance Point (IMD Third Order Intermodulation Inflection Point)	VBW _{res}	—	50	—	MHz
Gain Flatness in 60 MHz Bandwidth @ $P_{out} = 28\text{ W Avg.}$	G _F	—	0.2	—	dB
Gain Variation over Temperature (-30°C to $+85^\circ\text{C}$)	ΔG	—	0.011	—	dB/ $^\circ\text{C}$
Output Power Variation over Temperature (-30°C to $+85^\circ\text{C}$) ⁽²⁾	ΔP_{1dB}	—	0.012	—	dB/ $^\circ\text{C}$

1. Measurement made with device in a Doherty configuration.

2. Exceeds recommended operating conditions. See CW operation data in Maximum Ratings table.

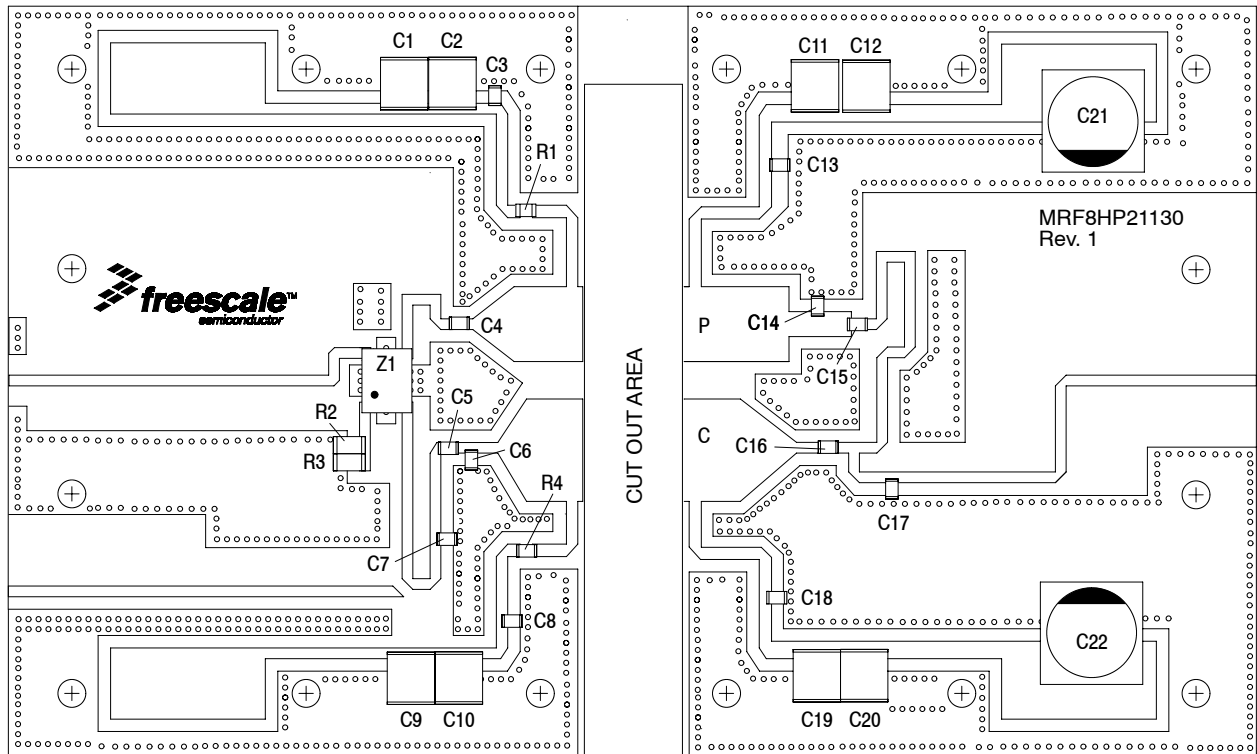


Figure 2. MRF8HP21130HR3(HSR3) Test Circuit Component Layout

Table 5. MRF8HP21130HR3(HSR3) Test Circuit Component Designations and Values

Part	Description	Part Number	Manufacturer
C1, C2, C9, C10, C11, C12, C19, C20	10 μ F Chip Capacitors	GRM55DR61H106KA88L	Murata
C3, C4, C5, C8, C13, C15, C16, C18	15 pF Chip Capacitors	ATC600F150JT250XT	ATC
C6	1.2 pF Chip Capacitor	ATC600F1R2BT250XT	ATC
C7	0.5 pF Chip Capacitor	ATC600F0R5BT250XT	ATC
C14	0.7 pF Chip Capacitor	ATC600F0R7BT250XT	ATC
C17	1 pF Chip Capacitor	ATC600F1R0BT250XT	ATC
C21, C22	220 μ F, 50 V Electrolytic Capacitors	EMVY500ADA221MJA0G	United Chemi-Con
R2, R3	100 Ω , 1/4 W Chip Resistors	CRCW1206100RFKEA	Vishay
R1, R4	10 Ω , 1/4 W Chip Resistors	CRCW120610R0JNEA	Vishay
Z1	2000–2300 MHz Band 90°, 3 dB Hybrid Coupler	X3C21P1-03S	Anaren
PCB	0.020", $\epsilon_r = 3.5$	R04350	Rogers

TYPICAL CHARACTERISTICS

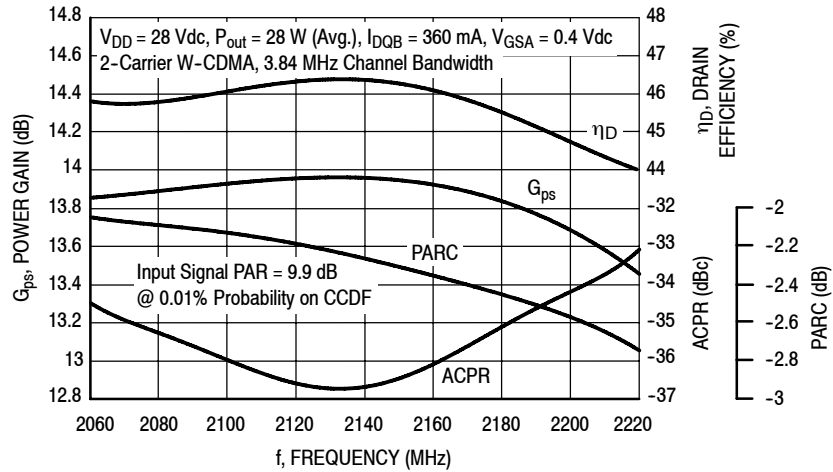


Figure 3. Output Peak-to-Average Ratio Compression (PARC) Broadband Performance @ $P_{out} = 28$ Watts Avg.

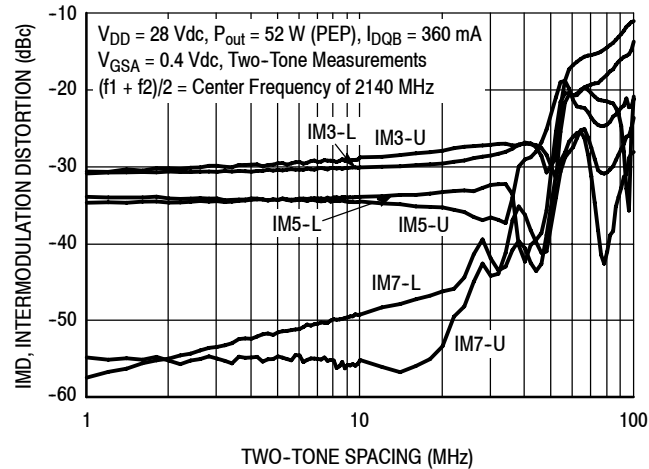


Figure 4. Intermodulation Distortion Products versus Two-Tone Spacing

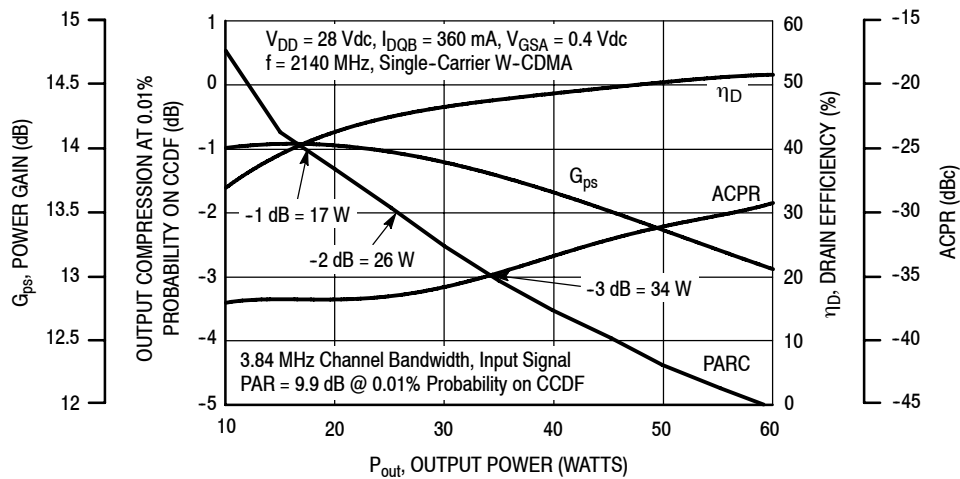


Figure 5. Output Peak-to-Average Ratio Compression (PARC) versus Output Power

TYPICAL CHARACTERISTICS

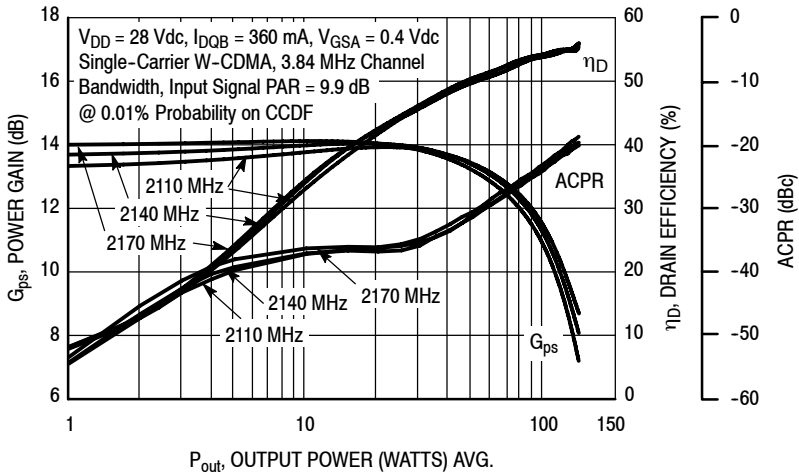


Figure 6. Single-Carrier W-CDMA Power Gain, Drain Efficiency and ACPR versus Output Power

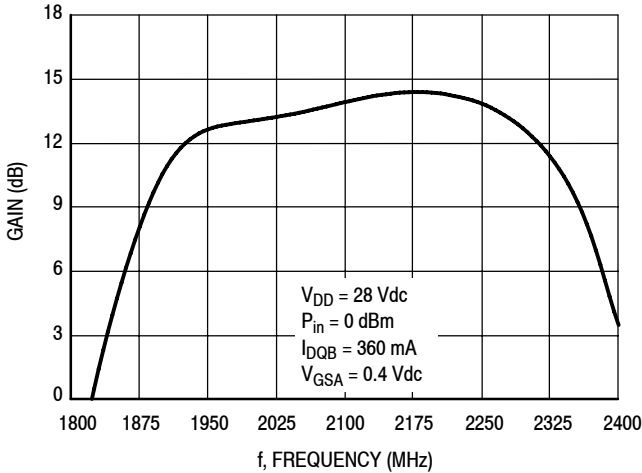


Figure 7. Broadband Frequency Response

W-CDMA TEST SIGNAL

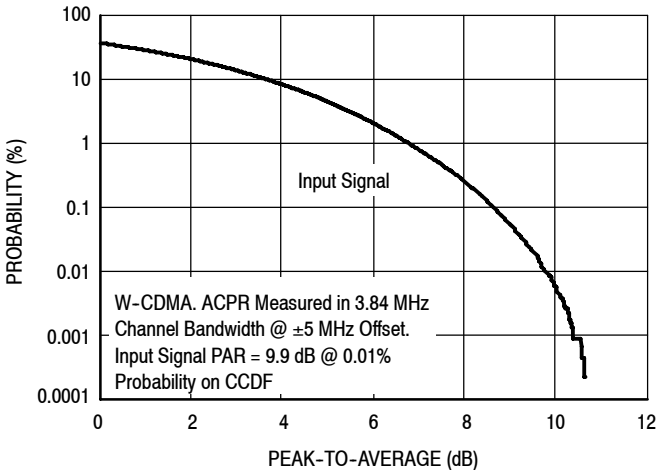


Figure 8. CCDF W-CDMA IQ Magnitude Clipping, Single-Carrier Test Signal

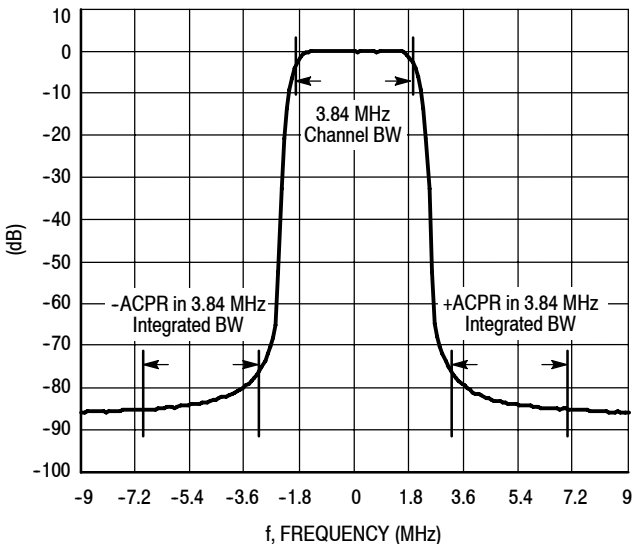


Figure 9. Single-Carrier W-CDMA Spectrum

$V_{DD} = 28 \text{ Vdc}$, $I_{DQB} = 360 \text{ mA}$, Pulsed CW, 10 $\mu\text{sec}(\text{on})$, 10% Duty Cycle

f (MHz)	Z_{source} (Ω)	$Z_{\text{load}}^{(1)}$ (Ω)	Max Output Power					
			P1dB			P3dB		
			(dBm)	(W)	η_D (%)	(dBm)	(W)	η_D (%)
2110	6.20 - j10.7	3.40 - j6.70	48.4	69	55.3	49.2	83	56.1
2140	7.80 - j11.5	3.40 - j6.80	48.4	69	55.5	49.2	83	55.3
2170	9.20 - j12.2	3.00 - j7.24	48.4	69	52.5	49.2	83	53.3

(1) Load impedance for optimum P1dB power.

Z_{source} = Impedance as measured from gate contact to ground.

Z_{load} = Impedance as measured from drain contact to ground.

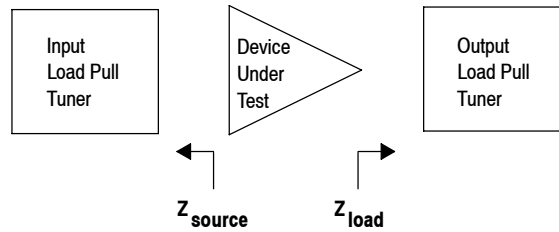


Figure 10. Carrier Side Load Pull Performance — Maximum P1dB Tuning

$V_{DD} = 28 \text{ Vdc}$, $I_{DQB} = 360 \text{ mA}$, Pulsed CW, 10 $\mu\text{sec}(\text{on})$, 10% Duty Cycle

f (MHz)	Z_{source} (Ω)	$Z_{\text{load}}^{(1)}$ (Ω)	Max Drain Efficiency					
			P1dB			P3dB		
			(dBm)	(W)	η_D (%)	(dBm)	(W)	η_D (%)
2110	6.20 - j10.7	7.60 - j6.30	46.8	48	63.5	48.0	63	64.1
2140	7.80 - j11.5	7.71 - j5.50	46.6	46	63.5	47.8	60	63.9
2170	9.20 - j12.2	6.40 - j5.60	47.0	50	62.3	47.8	60	62.5

(1) Load impedance for optimum P1dB efficiency.

Z_{source} = Impedance as measured from gate contact to ground.

Z_{load} = Impedance as measured from drain contact to ground.

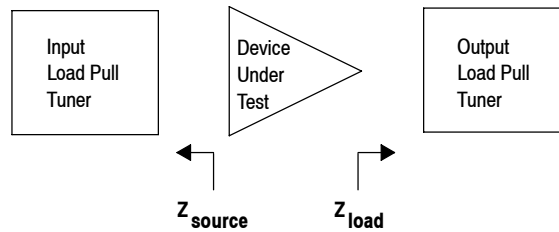


Figure 11. Carrier Side Load Pull Performance — Maximum Efficiency Tuning

$V_{DD} = 28 \text{ Vdc}$, $V_{GSA} = 0.4 \text{ Vdc}$, Pulsed CW, 10 $\mu\text{sec}(\text{on})$, 10% Duty Cycle

f (MHz)	Z_{source} (Ω)	$Z_{\text{load}}^{(1)}$ (Ω)	Max Output Power					
			P1dB			P3dB		
			(dBm)	(W)	η_D (%)	(dBm)	(W)	η_D (%)
2110	3.10 - j7.30	5.40 + j0.50	51.4	138	55.8	52.2	166	56.9
2140	3.77 - j7.80	5.00 + j1.80	51.2	132	54.4	52.0	158	56.7
2170	4.30 - j8.50	4.30 + j1.50	51.2	132	54.1	52.0	158	55.2

(1) Load impedance for optimum P1dB power.

Z_{source} = Impedance as measured from gate contact to ground.

Z_{load} = Impedance as measured from drain contact to ground.

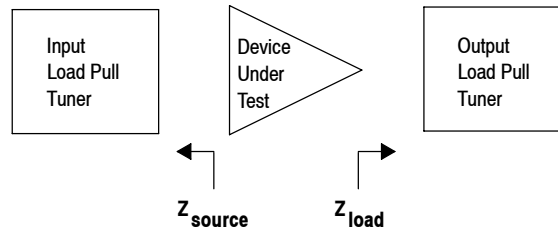


Figure 12. Peaking Side Load Pull Performance — Maximum P1dB Tuning

$V_{DD} = 28 \text{ Vdc}$, $V_{GSA} = 0.4 \text{ Vdc}$, Pulsed CW, 10 $\mu\text{sec}(\text{on})$, 10% Duty Cycle

f (MHz)	Z_{source} (Ω)	$Z_{\text{load}}^{(1)}$ (Ω)	Max Drain Efficiency					
			P1dB			P3dB		
			(dBm)	(W)	η_D (%)	(dBm)	(W)	η_D (%)
2110	3.10 - j7.30	4.80 - j5.20	49.1	81	67.2	51.0	126	68.2
2140	3.77 - j7.80	6.50 - j4.80	49.0	79	66.6	49.9	98	67.5
2170	4.30 - j8.50	6.90 - j4.90	48.8	76	66.7	49.9	98	67.4

(1) Load impedance for optimum P1dB efficiency.

Z_{source} = Impedance as measured from gate contact to ground.

Z_{load} = Impedance as measured from drain contact to ground.

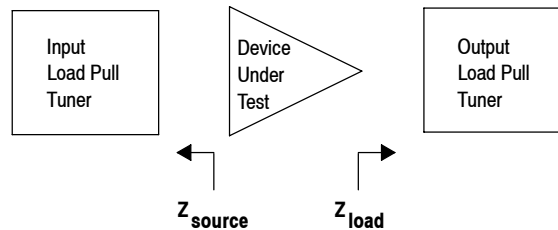
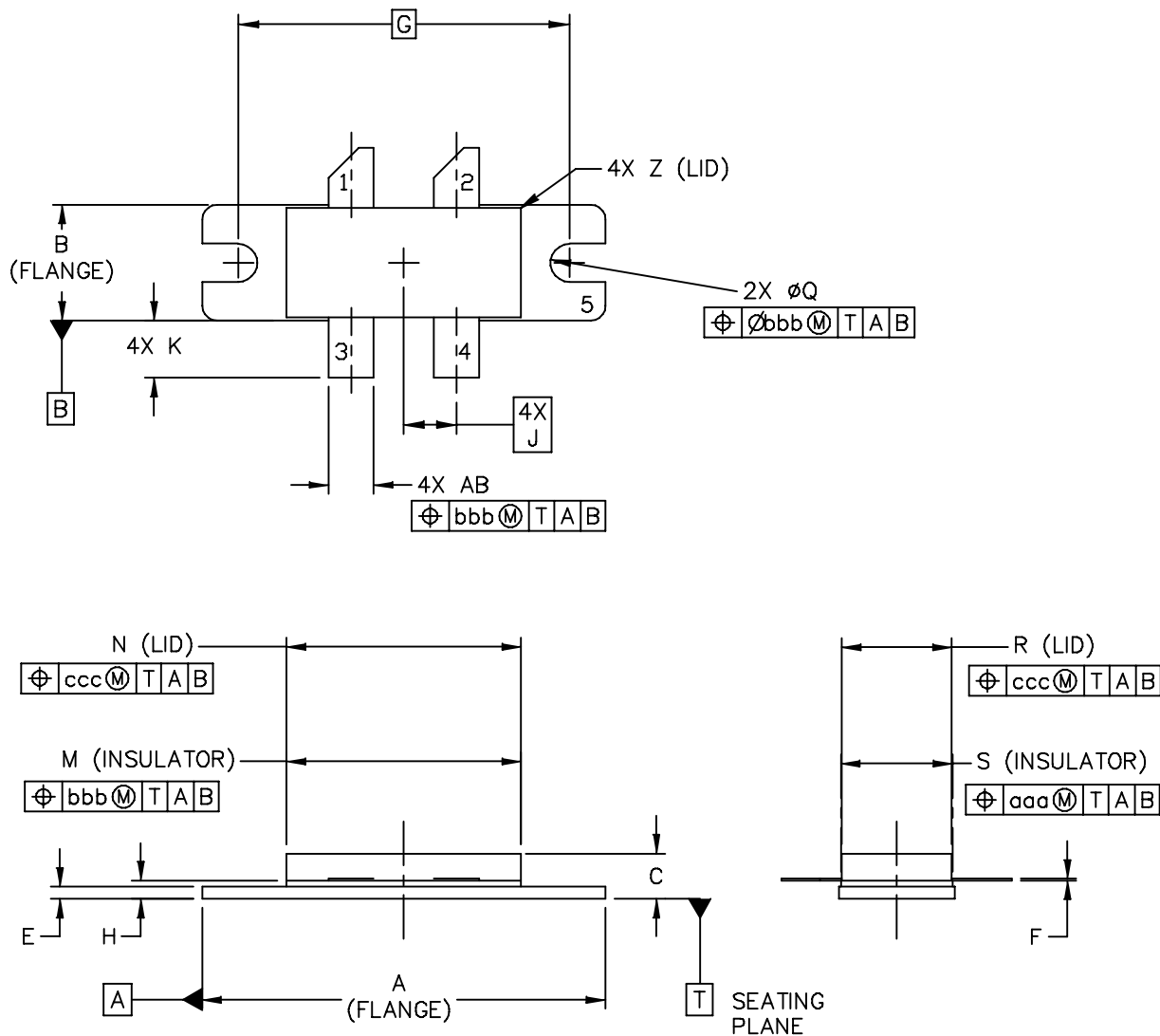


Figure 13. Peaking Side Load Pull Performance — Maximum Efficiency Tuning

PACKAGE DIMENSIONS



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TITLE: NI 780-4		DOCUMENT NO: 98ASA10793D		REV: 0	
		CASE NUMBER: 465M-01		27 MAR 2007	
		STANDARD: NON-JEDEC			

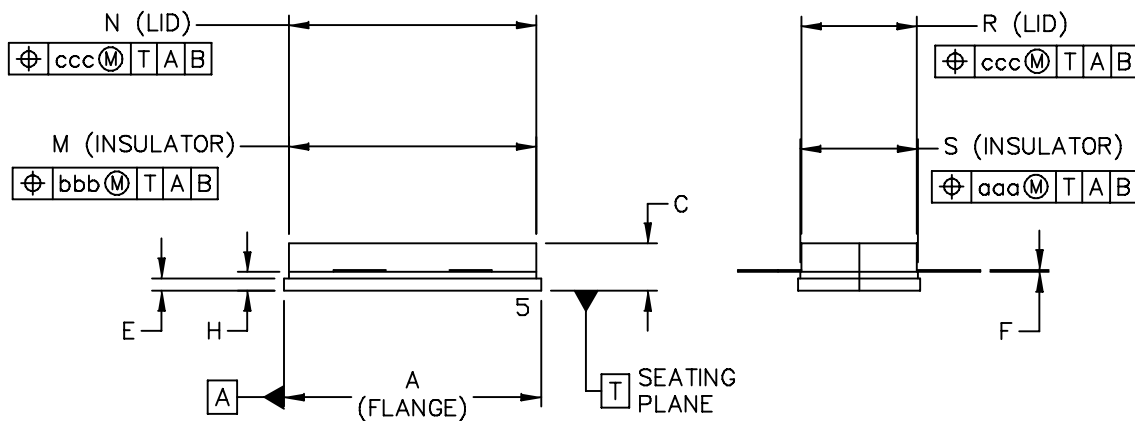
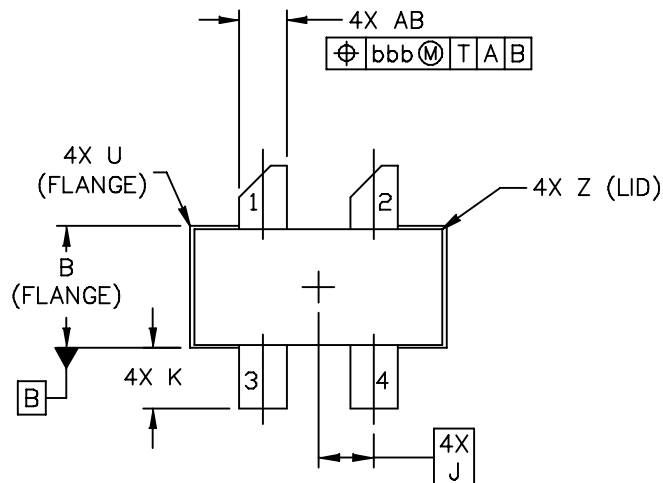
NOTES:

1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M-1994.
2. CONTROLLING DIMENSION: INCH.
3. DIMENSION H IS MEASURED .030 (0.762) AWAY FROM PACKAGE BODY.

STYLE 1:

- PIN 1. DRAIN
2. DRAIN
3. GATE
4. GATE
5. SOURCE

INCH			MILLIMETER		INCH			MILLIMETER	
DIM	MIN	MAX	MIN	MAX	DIM	MIN	MAX	MIN	MAX
A	1.335	1.345	33.91	34.16	R	.365	.375	9.27	9.53
B	.380	.390	9.65	9.91	S	.365	.375	9.27	9.52
C	.125	.170	3.18	4.32	U		.040		1.02
E	.035	.045	0.89	1.14	Z		.030		0.76
F	.003	.006	0.08	0.15	AB	.145	.155	3.68	3.94
G	1.100 BSC		27.94 BSC						
H	.057	.067	1.45	1.7	aaa	.005		0.127	
J	.175 BSC		4.44 BSC		bbb	.010		0.254	
K	.170	.210	4.32	5.33	ccc	.015		0.381	
M	.774	.786	19.61	20.02					
N	.772	.788	19.61	20.02					
Q	ø.118	ø.138	ø3	ø3.51					
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	CASE NUMBER: 465H-02		27 MAR 2007
	STANDARD: NON-JEDEC		

NOTES:

1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M-1994.
2. CONTROLLING DIMENSION: INCH.
3. DELETED
4. DIMENSION H IS MEASURED .030 (0.762) AWAY FROM PACKAGE BODY.

STYLE 1:

- PIN 1. DRAIN
2. DRAIN
3. GATE
4. GATE
5. SOURCE

INCH			MILLIMETER		INCH			MILLIMETER	
DIM	MIN	MAX	MIN	MAX	DIM	MIN	MAX	MIN	MAX
A	.805	.815	20.45	20.7	U		.040		1.02
B	.380	.390	9.65	9.91	Z		.030		0.76
C	.125	.170	3.18	4.32	AB	.145	.155	3.68	– 3.94
E	.035	.045	0.89	1.14					
F	.003	.006	0.08	0.15	aaa		.005		0.127
H	.057	.067	1.45	1.7	bbb		.010		0.254
J	.175 BSC		4.44 BSC		ccc		.015		0.381
K	.170	.210	4.32	5.33					
M	.774	.786	19.61	20.02					
N	.772	.788	19.61	20.02					
R	.365	.375	9.27	9.53					
S	.365	.375	9.27	9.52					
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TITLE: NI 780S-4					DOCUMENT NO: 98ASA10718D			REV: A	
					CASE NUMBER: 465H-02			27 MAR 2007	
					STANDARD: NON-JEDEC				

PRODUCT DOCUMENTATION AND SOFTWARE

Refer to the following documents and software to aid your design process.

Application Notes

- AN1955: Thermal Measurement Methodology of RF Power Amplifiers

Engineering Bulletins

- EB212: Using Data Sheet Impedances for RF LDMOS Devices

Software

- Electromigration MTTF Calculator
- .s2p File

For Software, do a Part Number search at <http://www.freescale.com>, and select the “Part Number” link. Go to the Software & Tools tab on the part’s Product Summary page to download the respective tool.

R5 TAPE AND REEL OPTION

R5 Suffix = 50 Units, 56 mm Tape Width, 13 inch Reel.

The R5 tape and reel option for MRF8HP21130H and MRF8HP21130HS parts will be available for 2 years after release of MRF8HP21130H and MRF8HP21130HS. Freescale Semiconductor, Inc. reserves the right to limit the quantities that will be delivered in the R5 tape and reel option. At the end of the 2 year period customers who have purchased these devices in the R5 tape and reel option will be offered MRF8HP21130H and MRF8HP21130HS in the R3 tape and reel option.

REVISION HISTORY

The following table summarizes revisions to this document.

Revision	Date	Description
0	Apr. 2011	• Initial Release of Data Sheet

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Tokyo 153-0064
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